

Search Notes

Application/Control No.

10/656,656

Examiner

John Q. Nguyen

Applicant(s)/Patent under
Reexamination

RATHWEG, CHRISTOPHER

Art Unit

3654

SEARCHED

Class	Subclass	Date	Examiner
242	338 338.1 338.4	7/5/2007 ↓	/JN/ ↓
360	93	↓	↓

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR